

<b>Notice of References Cited</b>	Application/Control No. 10/605,236	Applicant(s)/Patent Under Reexamination HUNG ET AL.	
	Examiner Kim Huynh	Art Unit 2182	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2004/0042138	03-2004	Saito et al.	361/090
	B	US-2004/0036895	02-2004	Yano et al.	358/1.6
	C	US-2002/0161844	10-2002	Overtoom, Eric J.	709/208
	D	US-6,732,218	05-2004	Overtoom et al.	710/313
	E	US-5,784,581	07-1998	Hannah, Eric C.	710/110
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 2004/029817 A1	05-2003	NL	Ng et al.	GO6F 13/38
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.